Docket No.

287800US26PCT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INVENTOR(S) Masayuki OIKAWA, et al.

SERIAL NO:

10/574,286

ART UNIT: 1797

FOR:

FILING DATE: March 31, 2006

EXAMINER: Cedric A. Chang

INSPECTION METHOD AND INSPECTION ASSISTING DEVICE FOR QUARTZ PRODUCT OF SEMICONDUCTOR PROCESSING APPARATUS

FEE TRANSMITTAL

No additional fee is required

Small entity status of this application under 37 C.F.R. §1.9 and §1.27 is claimed.

The Fee has been calculated as shown below:

FOR	NUMBER FILED	NUMBER EXTRA	RATE	CALCULATIONS
TOTAL CLAIMS	18 - 20 =	0	x \$52 =	\$0.00
INDEPENDENT CLAIMS	3 - 4 =	0	x \$220 =	\$0.00
☐ MULTIPLE DEPENDEN	T CLAIMS (If app	licable)	+ \$390 =	\$0.00
☐ LATE FILING OF DECI			+ \$130 =	\$0.00
LATETIENCE OF BEET			BASIC FEES	\$0.00
	TOTALO	F ABOVE CAL	CULATIONS	\$0.00
REDUCTION BY 50% FOR FILING BY SMALL ENTITY			\$0.00	
			+ \$130 =	\$0.00
☐ FILING IN NON-ENGL	SH LANGUAGE		TOTAL	\$0.00

Please charge Deposit Account No. 15-0030 in the amount of
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- The Director is hereby authorized to charge any additional fees which may be required for the papers being filed herewith and for which no payment is enclosed herewith, or credit any overpayment to Deposit Account No. 15-0030, with the EXCEPTION of deficiencies in fees for multiple dependent claims in new applications.
- If these papers are not considered timely filed by the Patent and Trademark Office, then a petition is hereby made under 37 C.F.R. §1.136, and any additional fees required under 37 C.F.R. §1.136 for any necessary extension of time may be charged to Deposit Account No. 15-0030.

Submitted by:

Steven P. Weihrouch Registration No. 32,829

Customer Number

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 09/09)

Ronald A. Rudder, Ph.D. Registration No. 45,618